



### General Description

The AON6926 is designed to provide a high efficiency synchronous buck power stage with optimal layout and board space utilization. It includes two specialized MOSFETs in a dual Power DFN5x6A package. The Q1 "High Side" MOSFET is designed to minimize switching losses. The Q2 "Low Side" MOSFET is an SRFET™ that features low  $R_{DS(ON)}$  to reduce conduction losses as well as an integrated Schottky diode with low  $Q_{RR}$  and  $V_f$  to reduce switching losses. The AON6926 is well suited for use in compact DC/DC converter applications.

### Product Summary

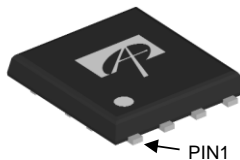
|                                    | Q1            | Q2             |
|------------------------------------|---------------|----------------|
| $V_{DS}$                           | 30V           | 30V            |
| $I_D$ (at $V_{GS}=10V$ )           | 44A           | 50A            |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )    | <11m $\Omega$ | <8.5m $\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS} = 4.5V$ ) | <14m $\Omega$ | <12m $\Omega$  |

100% UIS Tested  
100%  $R_g$  Tested

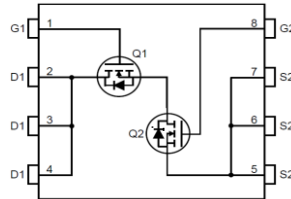
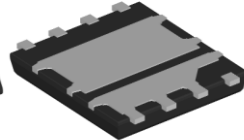


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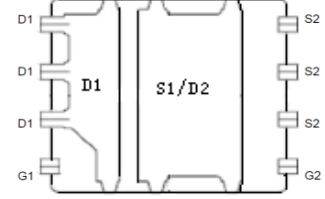
**Top View**



**Bottom View**



**Top View**



**Bottom View**

### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                                      | Symbol           | Max Q1     | Max Q2   | Units            |
|--|------------------|------------|----------|------------------|
| Drain-Source Voltage                           | $V_{DS}$         | 30         |          | V                |
| Gate-Source Voltage                            | $V_{GS}$         | $\pm 20$   | $\pm 20$ | V                |
| Continuous Drain Current                       | $I_D$            | 44         | 50       | A                |
|  |                  | 28         | 32       |                  |
| Pulsed Drain Current <sup>C</sup>              | $I_{DM}$         | 100        | 140      | A                |
| Continuous Drain Current                       | $I_{DSM}$        | 11         | 12       | A                |
|  |                  | 9          | 10       |                  |
| Avalanche Current <sup>C</sup>                 | $I_{AS}, I_{AR}$ | 27         | 15       | A                |
| Avalanche Energy $L=0.1\text{mH}$ <sup>C</sup> | $E_{AS}, E_{AR}$ | 36         | 11       | mJ               |
| Power Dissipation <sup>B</sup>                 | $P_D$            | 31         | 35       | W                |
|  |                  | 12.5       | 14       |                  |
| Power Dissipation <sup>A</sup>                 | $P_{DSM}$        | 1.9        | 2.1      | W                |
|  |                  | 1.2        | 1.3      |                  |
| Junction and Storage Temperature Range         | $T_J, T_{STG}$   | -55 to 150 |          | $^\circ\text{C}$ |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ Q1 | Typ Q2 | Max Q1 | Max Q2 | Units              |
|--|-----------------|--------|--------|--------|--------|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 29     | 24     | 35     | 29     | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A,D</sup> |                 | 56     | 50     | 67     | 60     | $^\circ\text{C/W}$ |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 3.4    | 3      | 4      | 3.6    | $^\circ\text{C/W}$ |

**Q1 Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions   | Min  | Typ       | Max      | Units |
|-----------------------------|---------------------------------------|--|------|-----------|----------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |  |      |           |          |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V   | 30   |           |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =125°C                         |      |           | 1<br>5   | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±20V  |      |           | 100      | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> I <sub>D</sub> =250μA                                     | 1.5  | 2         | 2.5      | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =10V, V <sub>DS</sub> =5V  | 100  |           |          | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =20A<br>T <sub>J</sub> =125°C                         |      | 8.8<br>12 | 11<br>15 | mΩ    |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A   |      | 11.2      | 14       | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =20A   |      | 55        |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V  |      | 0.74      | 1        | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |  |      |           | 35       | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |  |      |           |          |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz  | 920  | 1150      | 1380     | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |  | 125  | 180       | 235      | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |  | 60   | 105       | 150      | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz   | 0.55 | 1.1       | 1.65     | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |  |      |           |          |       |
| Q <sub>g(10V)</sub>         | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =20A                            | 16   | 20        | 24       | nC    |
| Q <sub>g(4.5V)</sub>        | Total Gate Charge                     |  | 7    | 9.5       | 11.4     | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |  |      | 2.7       |          | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |  |      | 5         |          | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =0.75Ω,<br>R <sub>GEN</sub> =3Ω |      | 6.5       |          | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |  |      | 2         |          | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |  |      | 17        |          | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |  |      | 3.5       |          | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =20A, dI/dt=500A/μs   | 7    | 8.7       | 10.5     | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =20A, dI/dt=500A/μs   | 11   | 13.5      | 16       | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150°C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25°C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150°C. The SOA curve provides a single pulse rating.

G. The maximum current rating is limited by package.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C.

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**Q2 Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions   | Min  | Typ        | Max        | Units |
|-----------------------------|---------------------------------------|--|------|------------|------------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |  |      |            |            |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V   | 30   |            |            | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =125°C                         |      |            | 0.5<br>100 | mA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±20V  |      |            | 100        | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> I <sub>D</sub> =250μA                                     | 1.2  | 1.9        | 2.4        | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =10V, V <sub>DS</sub> =5V  | 140  |            |            | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =20A<br>T <sub>J</sub> =125°C                         |      | 6.9<br>9.8 | 8.5<br>12  | mΩ    |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A   |      | 9.3        | 12         | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =20A   |      | 50         |            | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V  |      | 0.5        | 0.7        | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |  |      |            | 40         | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |  |      |            |            |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz  | 900  | 1130       | 1360       | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |  | 320  | 465        | 605        | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |  | 12   | 40         | 70         | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz   | 0.35 | 0.7        | 1.1        | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |  |      |            |            |       |
| Q <sub>g(10V)</sub>         | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =20A                            | 12   | 16         | 20         | nC    |
| Q <sub>g(4.5V)</sub>        | Total Gate Charge                     |  | 6    | 8          | 10         | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |  |      | 3          |            | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |  |      | 3          |            | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =0.75Ω,<br>R <sub>GEN</sub> =3Ω |      | 6          |            | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |  |      | 4          |            | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |  |      | 19         |            | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |  |      | 3          |            | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =20A, dI/dt=500A/μs   | 9    | 12         | 15         | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =20A, dI/dt=500A/μs   | 18   | 23         | 28         | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150°C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25°C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150°C. The SOA curve provides a single pulse rating.

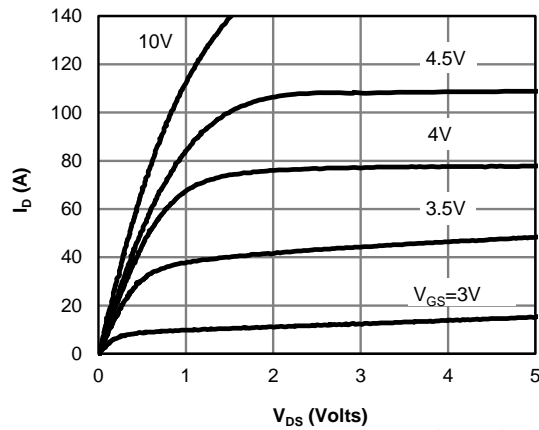
G. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C.

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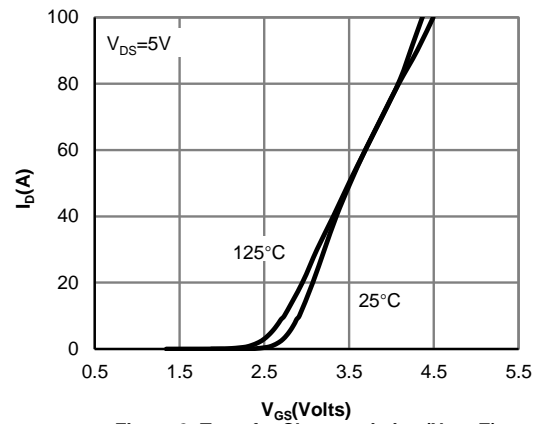
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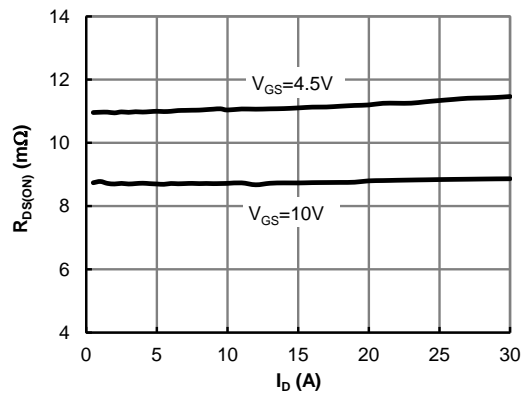
**Q1-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



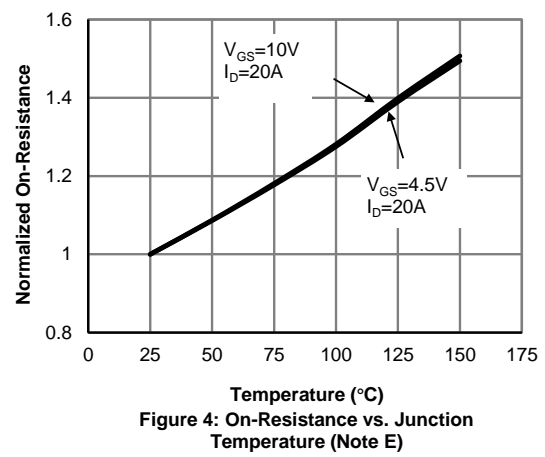
**Fig 1: On-Region Characteristics (Note E)**



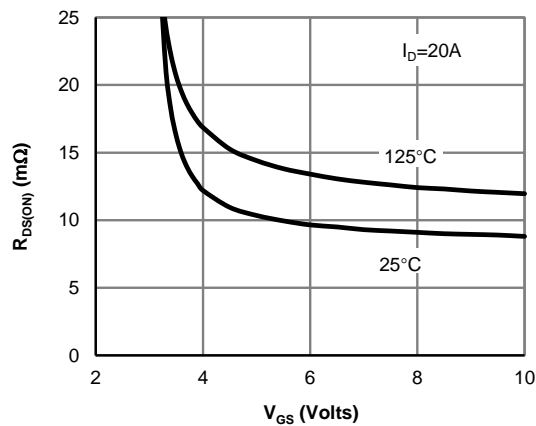
**Figure 2: Transfer Characteristics (Note E)**



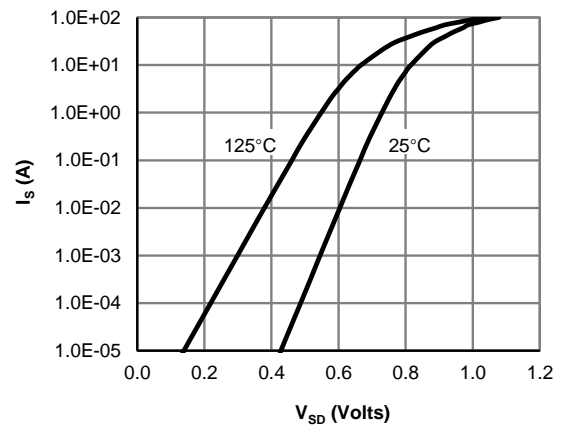
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

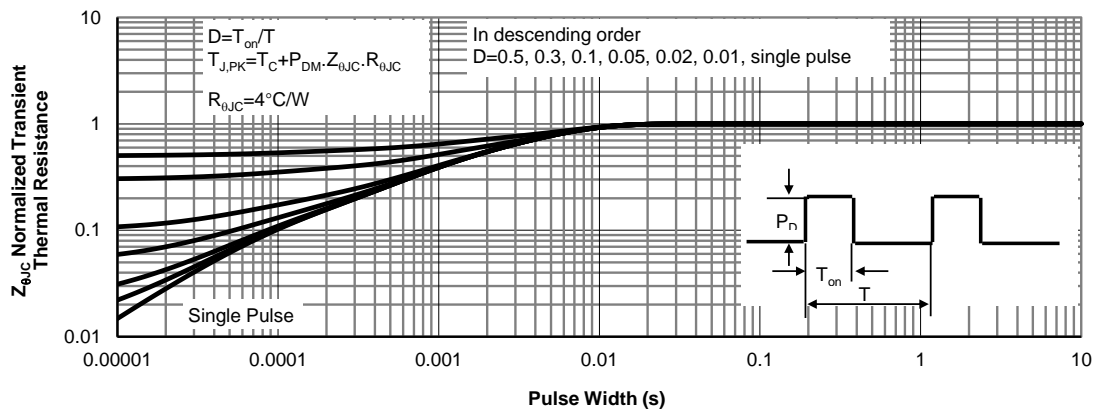
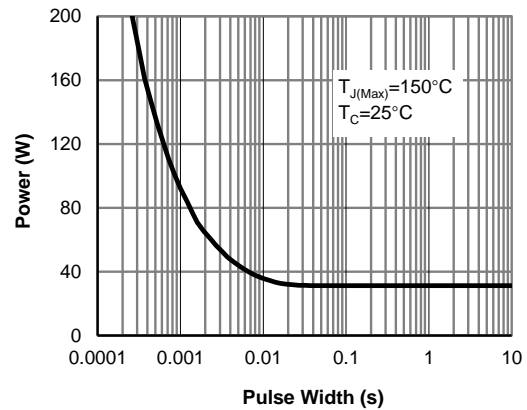
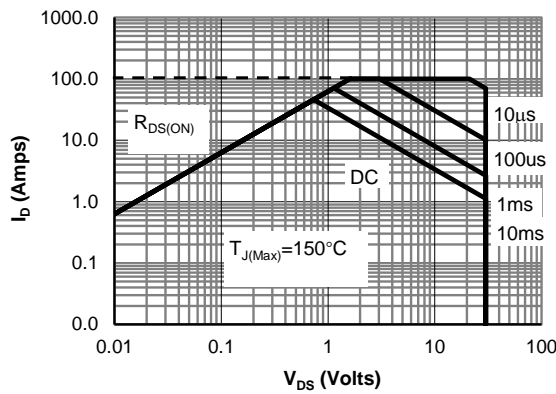
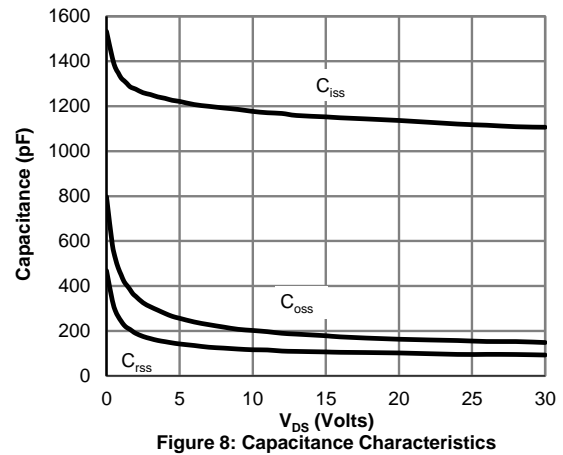
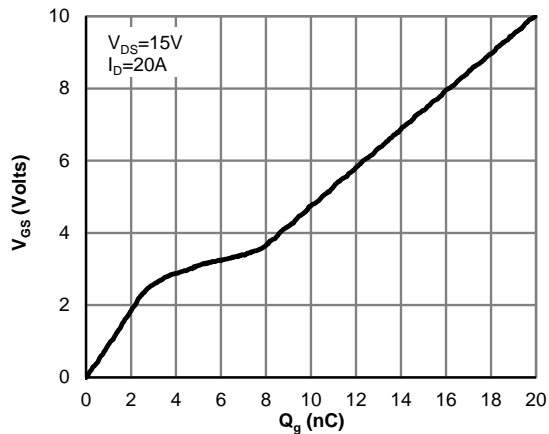


**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

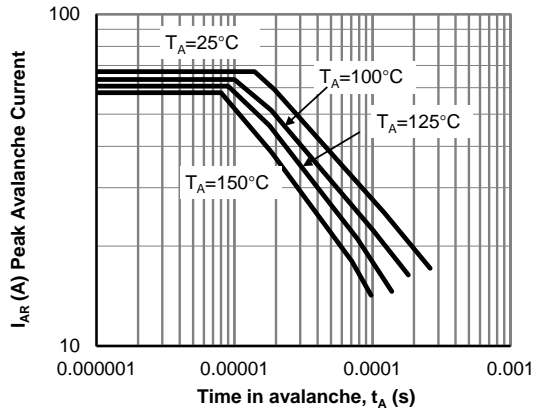


**Figure 6: Body-Diode Characteristics (Note E)**

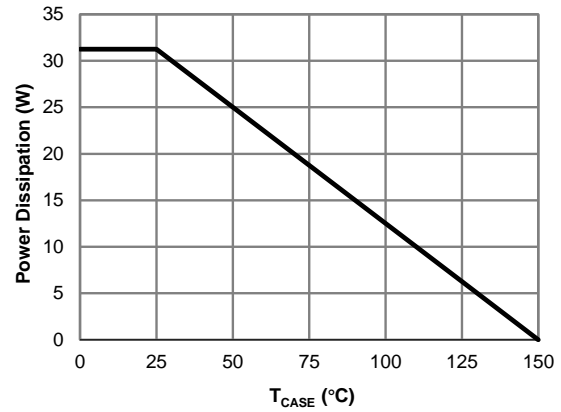
**Q1-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



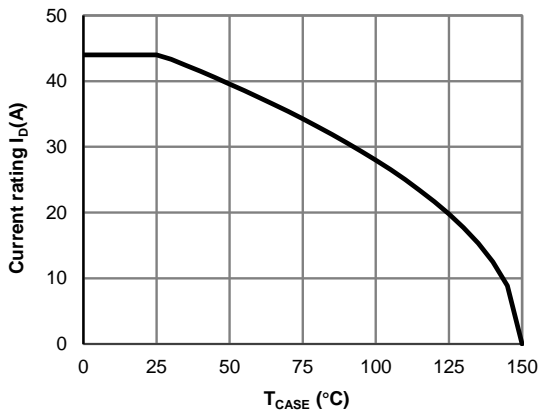
**Q1-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



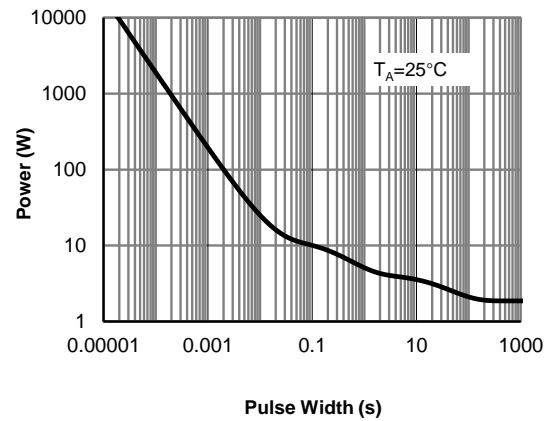
**Figure 12: Single Pulse Avalanche capability (Note C)**



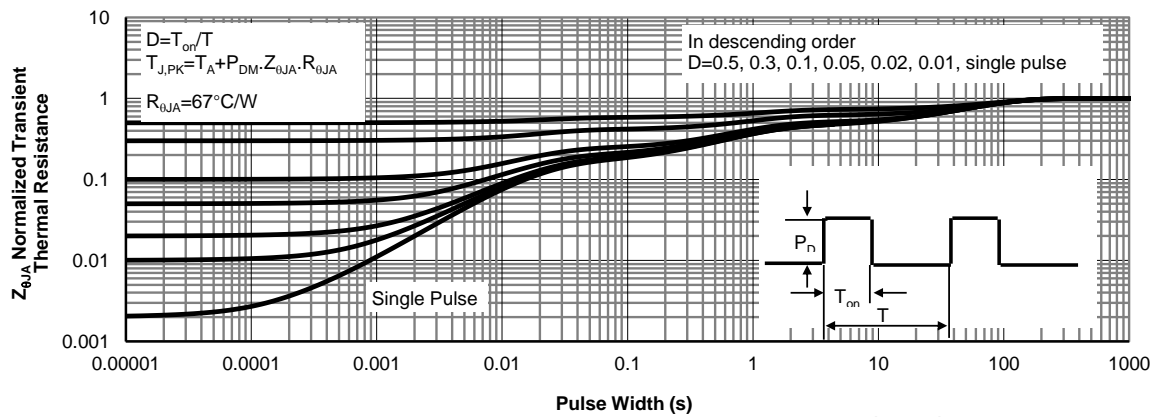
**Figure 13: Power De-rating (Note F)**



**Figure 14: Current De-rating (Note F)**

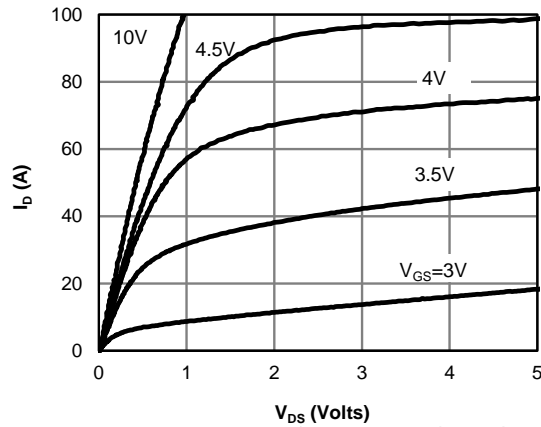


**Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)**

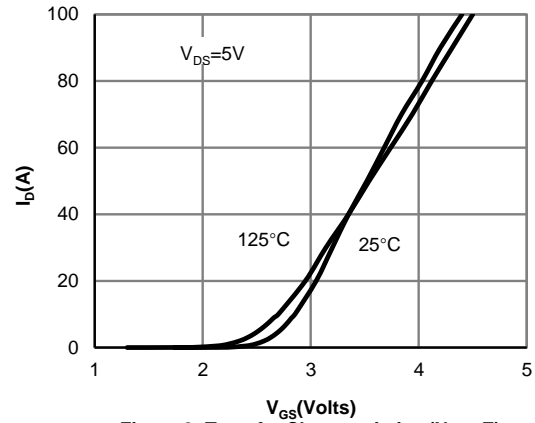


**Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)**

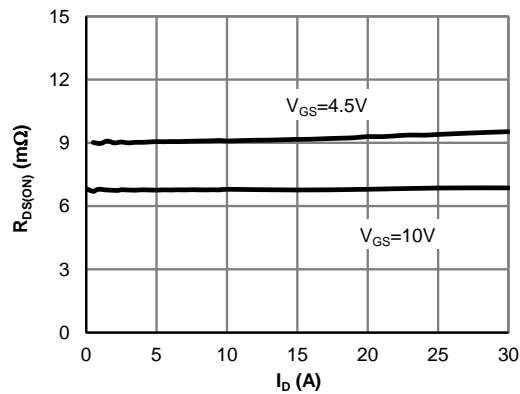
**Q2-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



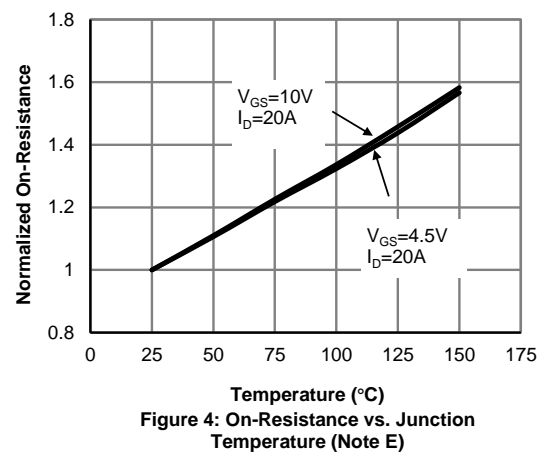
**Fig 1: On-Region Characteristics (Note E)**



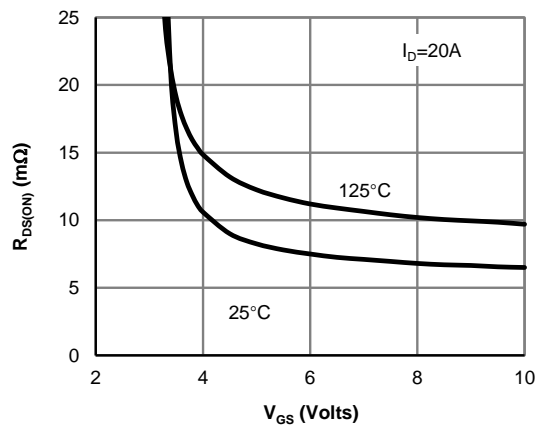
**Figure 2: Transfer Characteristics (Note E)**



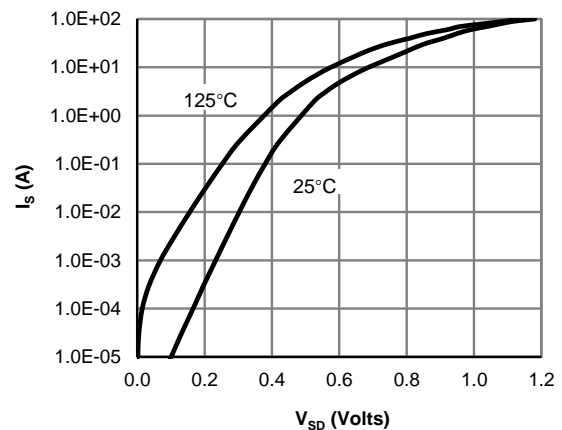
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

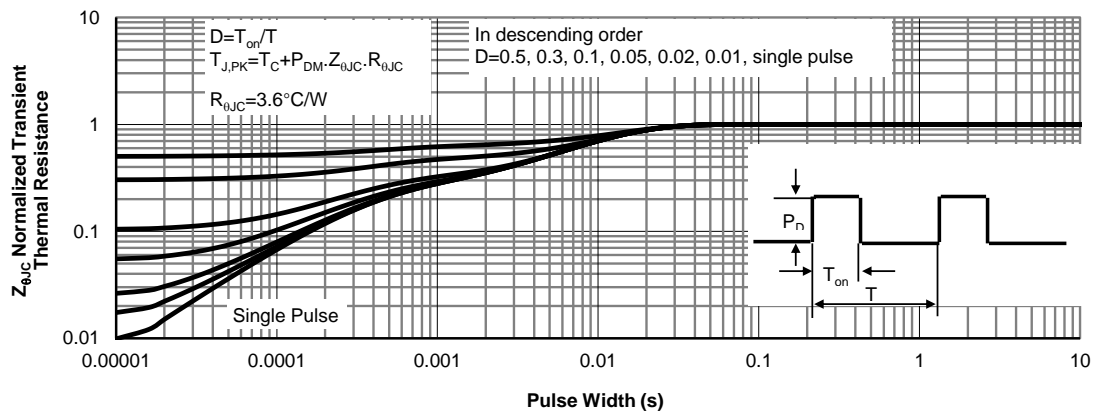
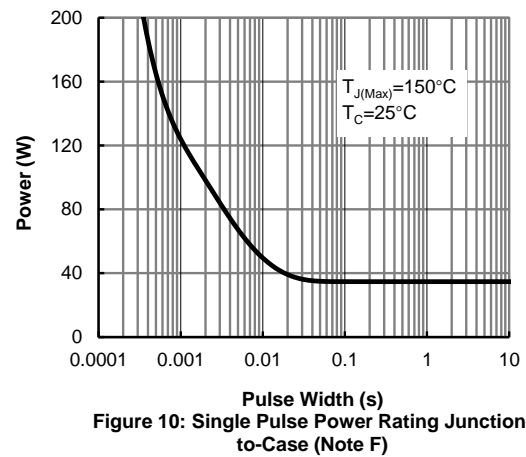
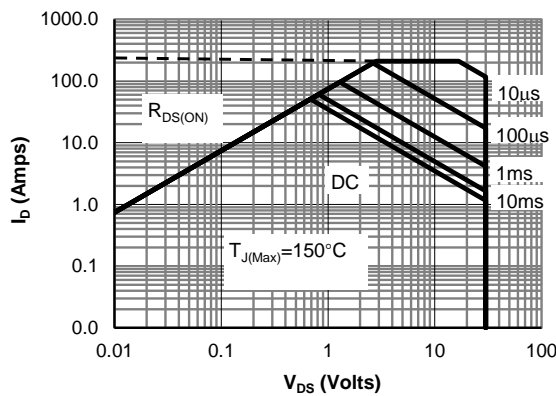
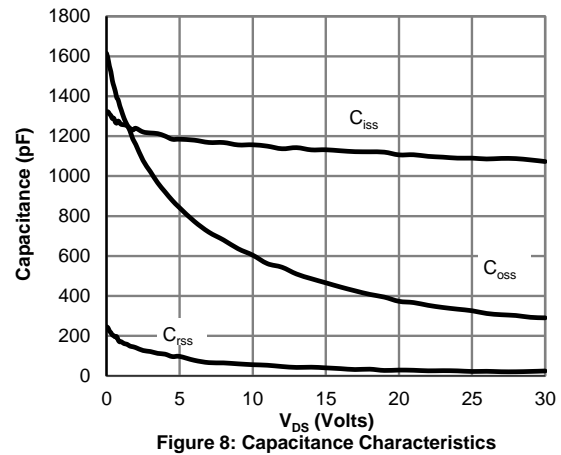
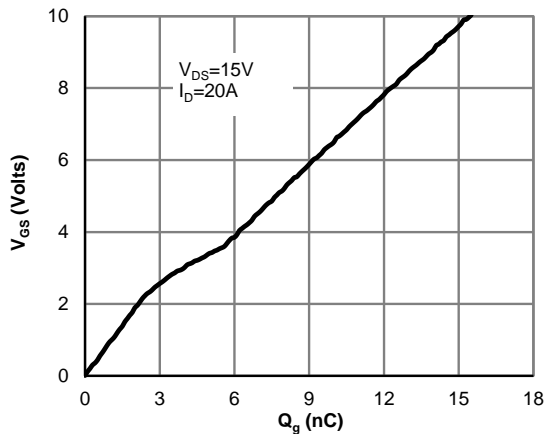


**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**



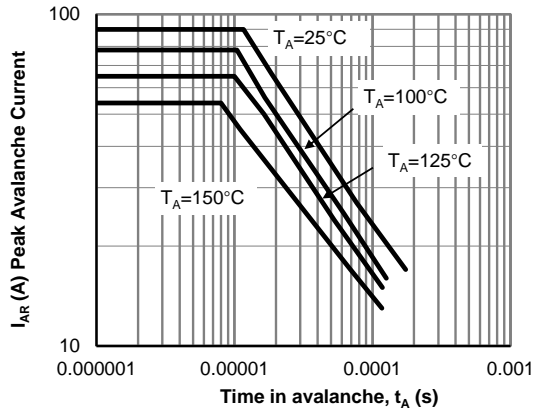
**Figure 6: Body-Diode Characteristics (Note E)**

**Q2-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

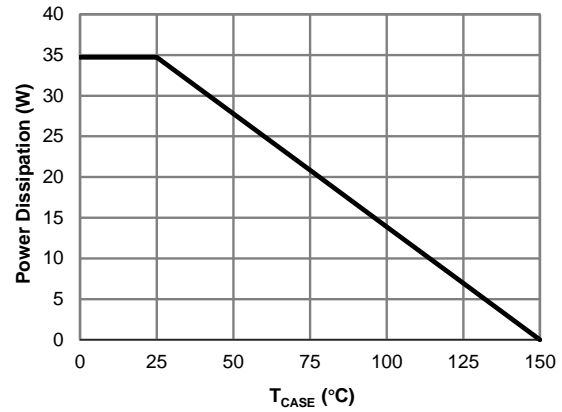




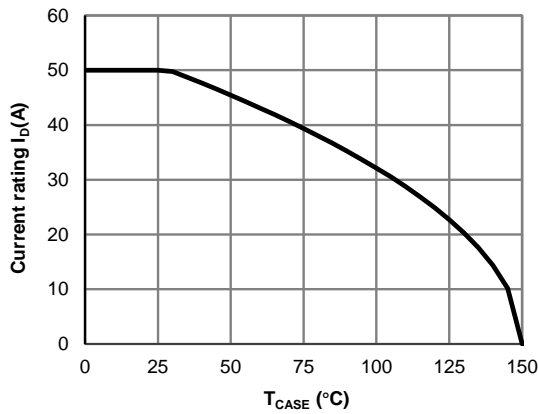
**Q2-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



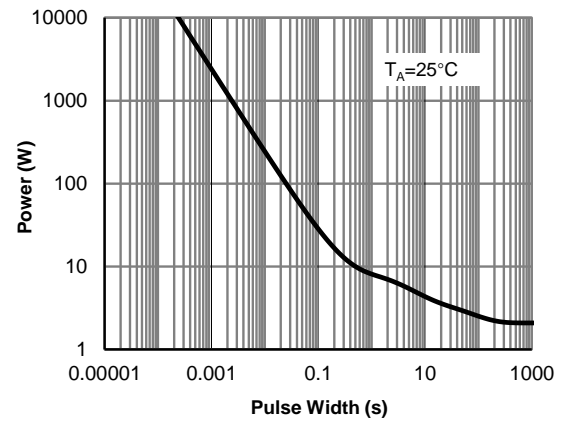
**Figure 12: Single Pulse Avalanche capability (Note C)**



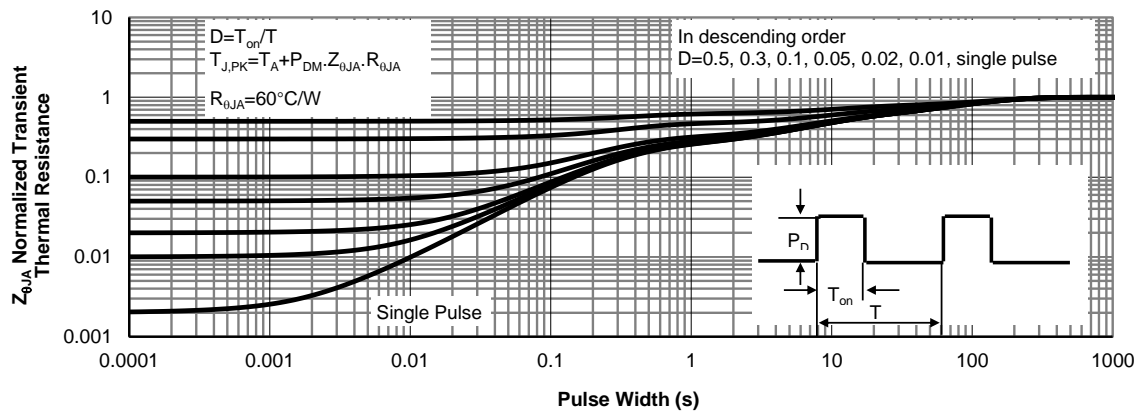
**Figure 13: Power De-rating (Note F)**



**Figure 14: Current De-rating (Note F)**

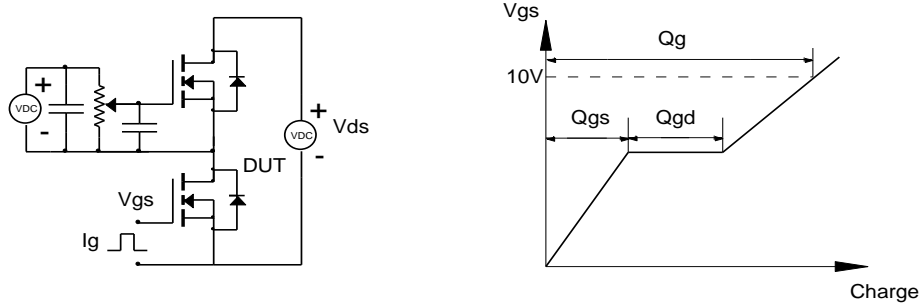


**Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note G)**

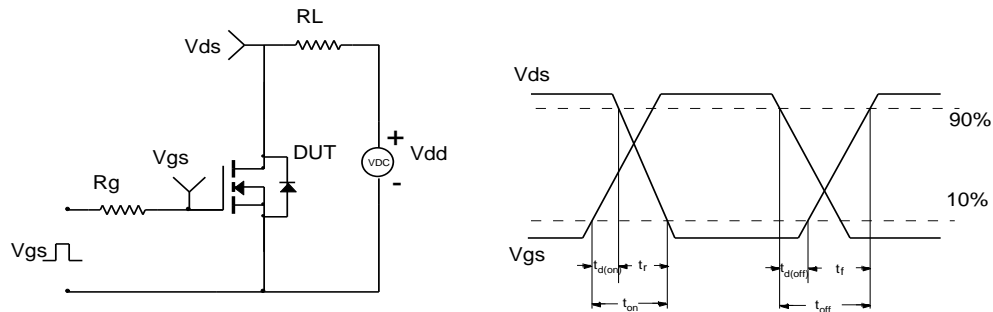


**Figure 16: Normalized Maximum Transient Thermal Impedance (Note G)**

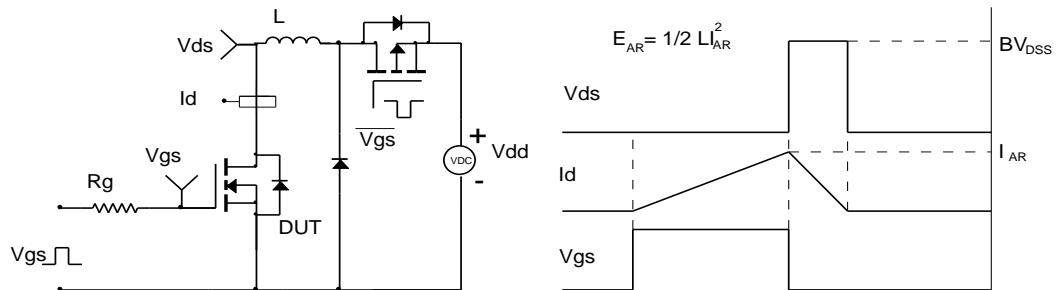
### Gate Charge Test Circuit & Waveform



### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



### Diode Recovery Test Circuit & Waveforms

